

Data sheet acquired from Harris Semiconductor SCHS080C – Revised July 2003

# CMOS BCD Rate Multiplier

High-Voltage Types (20-Volt Rating)

a CD4527B is a low-power 4-bit digital rate multiplier that provides an output-pulse rate which is the clock-input-pulse rate multiplied by 1/10 times the BCD input. For example, when the BCD input is 8, there will be 8 output pulses for every 10 input pulses. This device may be used to perform arithmetic operations (add, subtract, divide, raise to a power), solve algebraic and differential equations, generate natural logarithms and trigonometric functions, A/D and D/A conversion, and frequency division.

For fractional multipliers with more than one digit, CD4527B devices may be cascaded in two different modes: the Add mode and the Multiply mode. (See Figs.12 and 15). In the Add mode,

In the Multiply mode, the fraction programmed into the first rate multiplier is multiplied by the fraction programmed into the second one,

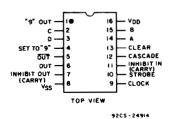
e.g. 
$$\frac{9}{10} \times \frac{4}{10} = \frac{36}{100}$$
 or 36 output

pulses for every 100 clock input pulses.

The CD4527B types are supplied in 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

#### Applications:

- Numerical control
- Instrumentation
- Digital filtering
- **■** Frequency synthesis



**TERMINAL ASSIGNMENT** 

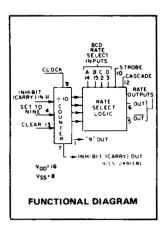
# CD4527B Types

#### Features:

- Cascadable in multiples of 4-bits
- Set to "9" input and "9" detect output
- = 100% test for quiescent current at 20 V
- = 5-V, 10-V, and 15-V parametric ratings
- Standardized, symmetrical output characteristics.
- Maximum input current of 1 µA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range) =

1 V at V<sub>DD</sub> ≠ 5 V 2 V at V<sub>DD</sub> = 10 V 2.5 ∀ at V<sub>DD</sub> = 1.5 V

 Meets all requirements of JEDEC Tentative Standard No. 13B, Standard Specifications for Description of 'B' Series CMOS Devices"



#### MAXIMUM RATINGS, Absolute-Maximum Values:

	DC SUPPLY-VOLTAGE RANGE, (V <sub>DD</sub> )
0.5V to +20V	Voltages referenced to VSS Terminal)
0.5V to V <sub>DD</sub> +0.5V	INPUT VOLTAGE RANGE, ALL INPUTS
±10mA	DC INPUT CURRENT, ANY ONE INPUT
(P <sub>D</sub> ):	POWER DISSIPATION PER PACKAGE (F
500mW	For $T_A = -55^{\circ}C$ to $+100^{\circ}C$
Derate Linearity at 12mW/°C to 200mW	For TA = +100°C to +125°C
	DEVICE DISSIPATION PER OUTPUT TRA
ATURE RANGE (All Package Types) 100mW	FOR TA = FULL PACKAGE-TEMPERA
(T <sub>A</sub> )55°C to +125°C	OPERATING-TEMPERATURE RANGE (T
tg)65°C to +150°C	
	LEAD TEMPERATURE (DURING SOLDE
0.79mm) from case for 10s max +265°C	At distance $1/16 \pm 1/32$ inch $(1.59 \pm 0.7)$

# RECOMMENDED OPERATING CONDITIONS AT $T_A = 25^{\circ}C$ , Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CUA DA OTERIOTIO	V <sub>DD</sub>	LIN	MITS	
CHARACTERISTIC	(V)	Min.	Max.	UNITS
Supply Voltage Range (For TA = Full Package Temperature Range)		3	18	٧
Set or Clear Pulse Width, tw	5 10 15	160 90 60	+	ns
Clock Pulse Width, t <sub>W</sub>	5 10 15	330 170 100		ns
Clock Frequency, fCL	5 10 15	dc	1.2 2.5 3.5	MHz
Clock Rise or Fall Time, trCL or tfCL	5,10,15	_	15	μs
Inhibit In Setup Time, tSU	5 10 15	100 40 20	- - -	ns
Inhibit In Removal Time, tREM	5 10 15	240 130 110	_ _ _	ns
Set Removal Time, tREM	5 10 15	150 80 50	_ _ _	ns
Clear Removal Time, t <sub>REM</sub>	5 10 15	60 40 30	- - -	ns

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#### CD4527B Types

#### STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	CONE	HOITION	IS	LIMI	LIMITS AT INDICATED TEMPERATURES (°C)							
ISTIC	vo	VIN	$v_{DD}$						+25		UNIT	
	(V)	(V)	(V)	<b>-55</b>	-40	+85	+125	Min.	Тур.	Max.		
Quiescent Device	-	0,5	5	5	5	150	150	-	0.04	5		
Current,		0,10	10	10	10	300	300		0.04	10	μΑ	
IDD Max.		0,15	15	20	20	600	600	- :	0.04	20	"^	
	_	0,20	20	100	100	3000	3000	-	0.08	100		
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1	-	$\vdash$	
(Sink) Current IOL Min.	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	-	1	
	1.5	0,15	15	4.2	4	2.8	2.4	34	6.8	-		
Output High	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	1	_	mA	
(Source)	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	-	1	
Current,	9.5	0,10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6			
IOH Min.	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	6.8	-		
Output Voltage:	-	0,5	5		0	.05		-	0	0.05		
Low-Level, VOL Max.	-	0,10	10		0	.05		-	0	0.05		
AOF Max.	-	0,15	15		ō	.05		-	0	0.05	. v	
Output Voltage:	-	0,5	5		4	.95		4.95	5	-		
High-Level,		0,10	10		9	.95		9.95	-10	-		
VOH Min.		0,15	15		14	1.95		14.95	15	_		
Input Low	0.5, 4.5	_	5		1	.5		-		1.5		
Voltage,	1, 9	_	10			3	-	-	_	3		
VIL Max.	1.5, 13.5	_	15			4			_	4		
Input High	0.5, 4.5	_	5		:	3.5		3.5	_	-	\ \	
Voltage,	1, 9	_	10			7		7		1		
VIH Min.	1.5,13,5	_	15			11		11	_	_		
Input Current IIN Max.		0,18	18	±0.1	±0.1	±1	±1	-	±10-5	±0.1	μА	

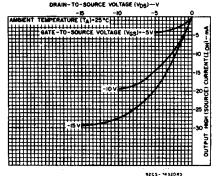


Fig.3 — Typical output high (source) current characteristics.

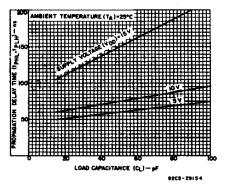


Fig.6 — Typical propagation delay time as a function of load capacitance (Clock or Strobe to Out).

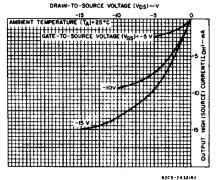


Fig.4 - Minimum output high (source) current characteristics.

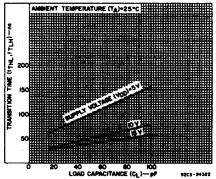


Fig.7 — Typical transition time as a function of load capacitance.

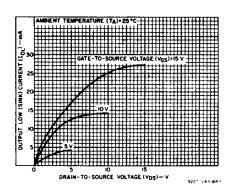


Fig. 1 — Typical output low (sink) current characteristics.

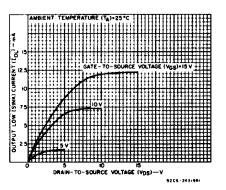


Fig.2 – Minimum output low (sink) current characteristics.

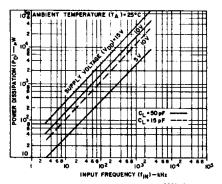


Fig.5 — Typical dynamic power dissipation as a function of input frequency.

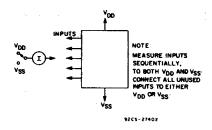


Fig.8 - Input current test circuit.

## CD4527B Types

# DYNAMIC ELECTRICAL CHARACTERISTICS at T $_{A}$ = 25°C: Input t, tf = 20 ns, C $_{L}$ = 50 pF, R $_{L}$ = 200 k $\Omega$

	TEST COND	ITIONS	<u> </u>	LIMITS	<u> </u>	<u> </u>
CHARACTERISTIC		V <sub>DD</sub>	Min.	Тур.	Max.	UNITS
Brancastica Dalau Tima and an annual		5	_	110	220	
Propagation Delay Time, tPHL, tPLH Clock to Out		10	- 1	55	110	
Clock to Out		15	-	45	90	20
1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 -		5	_	150	300	ns
Clock or Strobe to Out		10	-	75	150	
		15	_	60	120	
Clock to Inhibit Out		5	· -	320	640	
High Level to Low Level		10	-	145	290	
		15	_	100	200	ns
		5	-	250	500	l ''3
Low Level to High Level	ł	10		100	200	
	ļ <u> </u>	15		75	150	
		5	-	380	760	
Clear to Out		10	-	175	350	
·		15	-	130	260	ns
	1	5	- 1	300	600	,,,,
Clock to "9" or "15" Out		10	-	125	250	
		15		90	180	
		5	- 1	90	180	
Cascade to Out		10	-	45	90	
		15		35	70	ns
		5	-	130	260	
Inhibit In to Inhibit Out		10	_	60	120	
	<del> </del>	15		45	90	
		5	-	330	660	
Set to Out	i i	10	-	150	300	
		15		110	220	ns
Tanadaina Tiana	-	5	- 1	100	200	
Transition Time, t <sub>THL</sub> , t <sub>TLH</sub>	1	10 15	-	50	100	
				40	80	
Maximum Clock Frequency, f <sub>CL</sub>		. 5	1.2	2.4	-	
Maximum Clock Frequency, ICL	1	10 15	2.5 3.5	5 7		MHz
	<del> </del> -	5	-		-	
Minimum Clock Pulse Width, tw		10	-	165 85	330 170	
www.midth clock i dise width, tw	1	15	- 1	50	100	ns
		5			15	
Clock Rise or Fall Time, trCL, tfCL	1	10	_		15	μs
Close this or Fair time, GCE, GCE	]	15	_	_	15	μι
		5	_	80	160	
Minimum Set or Clear Pulse Width, tw		10	_	45	90	
		15	-	30	60	
		5	_	50	100	ns
Minimum Inhibit In Setup Time, tSU		10	_ 1	20	40	
		15		10	20	
Minimum Inhibit to Descript Time		5	_	120	240	
Minimum Inhibit In Removal Time,		10	_	65	130	
trem trem	L	15		<b>5</b> 5	110	
		5	-	75	150	ns .
Minimum Set Removal Time, tREM		10	-	40	80	
·		15		25	50	
	[	5	-	30	60	
Minimum Clear Removal Time, TREM		10	-	20	40	ns
		15		15	30	
Input Capacitance, CIN	Any Input		-	5	7.5	ρF

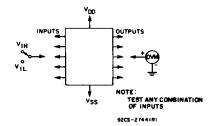


Fig.9 - Input voltage test circuit.

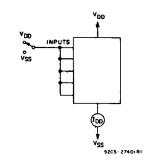


Fig. 10 - Quiescent device current test circuit.

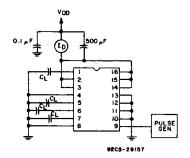


Fig. 11 - Dynamic power dissipation test circuit.

#### **APPLICATIONS**

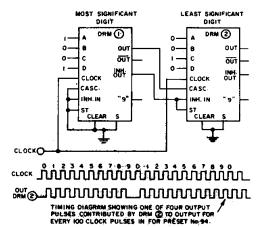


Fig.12 - Two CD45278's cascaded in the "Add" mode with a preset number

of 94 
$$\left(\frac{9}{10} + \frac{4}{100} = \frac{94}{100}\right)$$
.

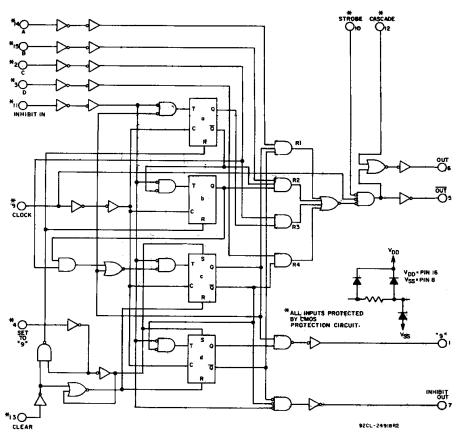
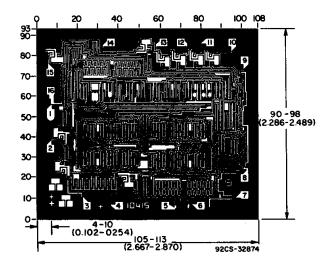


Fig. 13 — Logic diagram.



Dimensions and Pad Layout for CD4527BH

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils ( $10^{-3}$  inch).

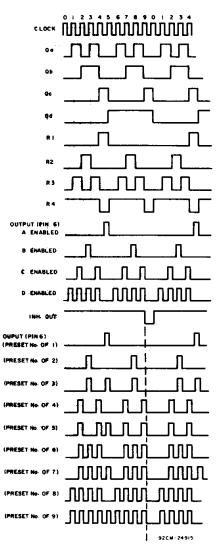


Fig. 14 - Timing diagram (See Logic Diagram).

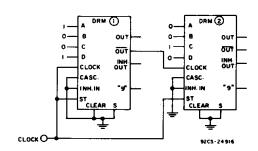


Fig. 15 — Two CD4527B's cascaded in the "Multiply" mode with a preset number of  $36\left(\frac{9}{10}\times\frac{4}{10}=\frac{36}{100}\right)$ .

## CD4527B Types

**TRUTH TABLE** 

						Γ'''	OUTPL	JTS					
			i	nput	er of Pu Logic L ow; 1 =	0	umber of utput Log	Pulses o	)				
D	ç	В	A	CLK	INH IN	STR	CAS	CLR #	SET #	OUT	OUT	INH	"9" OUT
0	0.	o	0	10	0	0	0	0	0	L	Н	1	1
0	0	0	1	10	0	0	0	0	0	1	1	1	1
0	0	1	0	10	0	0	0	0	0	2	2	1 1	1
0	0	1	1	10	0	0	0	0	0	3	3	1	1
0	1	0	Q	10	0	0	0	0	0	4	4	1	1
0	1	0	1	10	0	0	0	0	0	5	5	1 1	1
0	1	1	0	10	0	0	0	0	0	6	6	1	1 1
0	1	1	1	10	0	0	0	0	0	7	7	1	1
1	0	0	0	10	0	0	0	0	0	8	8	1	1
1	0	0	1	10	0	0	0	0	0	9	9	1	1
1	0	1	0	10	0	-0	0	O	0	8	8	1	1
1	0	1	1	10	0	0	Ö	0	0	9	9	1	1
1	1	0	0	10	0	0	0	0	0	8	8	1	1
1	1	0	1	10	0	0	0	0	0	9	9	1	1
1	1	1	0	10	0	0	0	0	0	8	8	1	1
1	1	1	1	10	0	0	0	0	0	9	9	1	1
x	X	х	x	10	1	0	0	0	0	†	†	н	+
x		x	x	10	o	1	0	o	0	Ĺ	н	1	' <b>,</b>
X	X		х	10	ō	Ö	1	0	o ·	H	*	i	i
1	х	x	X	10	0	0	0	1	0	10	10	Н	L
0	Х	X	X	10	0	0	0	1	0	L	H	н	ŭ
X	X	X	х	10	0	0	0	0	1	L	н	L	н

<sup>\*</sup> Output same as the first 16 lines of this truth table (depending on values of A, B, C, D).

†Depends on internal state of counter.

<sup>#</sup>Clear and Set Inputs should not be high at the same time; device draws increased quiescent current when in this non-valid state.





11-Apr-2013

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
CD4527BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD4527BE	Samples
CD4527BEE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD4527BE	Samples
CD4527BNSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4527B	Samples
CD4527BNSRE4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4527B	Samples
CD4527BNSRG4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4527B	Samples
CD4527BPW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM527B	Samples
CD4527BPWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM527B	Samples
CD4527BPWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM527B	Samples
CD4527BPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM527B	Samples
CD4527BPWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM527B	Samples
CD4527BPWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM527B	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



#### PACKAGE OPTION ADDENDUM

11-Apr-2013

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above. **Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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## PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4527BNSR	so	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4527BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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#### \*All dimensions are nominal

Device	Package Type	Package Type Package Drawing		SPQ	Length (mm)	Width (mm)	Height (mm)
CD4527BNSR	SO	NS	16	2000	367.0	367.0	38.0
CD4527BPWR	TSSOP	PW	16	2000	367.0	367.0	35.0

# N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



PW (R-PDSO-G16)

### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G16)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



#### **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



#### IMPORTANT NOTICE

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